


<b>Search Notes</b> 	<b>Application/Control No.</b> 10674962	<b>Applicant(s)/Patent Under Reexamination</b> BANTZ ET AL.
	<b>Examiner</b> Liu, Lin	<b>Art Unit</b> 2145

SEARCHED			
Class	Subclass	Date	Examiner
709	238, 239	06/26/2007	L.L

SEARCH NOTES		
Search Notes	Date	Examiner
Text search of USPAT, USPGPUB, EPO, JPO, DERWENT, IBM_TDB, see search history printout.	06/26/2007	L.L
Limited classified search of 709/224, 225, 226, 228,	06/26/2007	L.L
L1: 709/238.ccls. and (@ad<20030930) reviewed consicely	06/26/2007	L.L
709/238.ccls. not L1, reviewed cursory.	06/26/2007	L.L
Diaglog search attached	06/26/2007	L.L
Text search of USPAT, USPGPUB, EPO, JPO, DERWENT, IBM_TDB, see search history printout.	12/18/2007	L.L
Text search of USPAT, USPGPUB, EPO, JPO, DERWENT, IBM_TDB, see search history printout.	02/27/2008	L.L
Text search of USPAT, USPGPUB, EPO, JPO, DERWENT, IBM_TDB, see search history printout.	08/20/2008	L.L
text searched with 709/224-226, 228, 238	08/20/2008	L.L
Google Patent search attached.	08/20/2008	L.L

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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